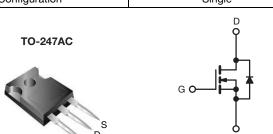


## **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	0.28			
Q <sub>g</sub> (Max.) (nC)	130				
Q <sub>gs</sub> (nC)	33				
Q <sub>gd</sub> (nC)	59				
Configuration	Single				



#### N-Channel MOSFET

#### **FEATURES**

• SuperFast Body Diode Eliminates the Need For External Diodes in ZVS Applications



- Low Gate Charge Results in Simple Drive Requirement
- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise **Immunity**
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supply
- Motor Control applications

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP17N50LPbF		
Lead (FD)-ifee	SiHFP17N50L-E3		
SnPb	IRFP17N50L		
SHED	SiHFP17N50L		

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	500		
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Dusin Comment	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	16		
Continuous Drain Current		T <sub>C</sub> = 100 °C		11	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	64		
Linear Derating Factor				1.8	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	390	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	16	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	22	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			P <sub>D</sub>	220	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	13	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150		
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>	°C	
Mariatha Tana	0.00			10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw			1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T<sub>J</sub> = 25 °C, L = 3.0 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 16 A (see fig. 12).
- c.  $I_{SD} \le 16$  Å,  $dI/dt \le 347$  Å/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP17N50L, SiHFP17N50L



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	=	0.56		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						•	,
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$		e to 25 °C, I <sub>D</sub> = 1 mA <sup>d</sup>	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
Zana Oata Valta aa Dusia Oomoat		V <sub>DS</sub> =	= 500 V, V <sub>GS</sub> = 0 V	-	-	50	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 9.9 A^b$	-	0.28	0.32	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> :	= 50 V, I <sub>D</sub> = 9.9 A <sup>b</sup>	11	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	2760	-	
Output Capacitance	Coss		$V_{DS} = 25 \text{ V},$	-	325	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	37	-	
Output Canacitanas	0		V <sub>DS</sub> = 1.0 V , f = 1.0 MHz		3690	-	pF
Output Capacitance	$C_{oss}$	V <sub>DS</sub> = 400 V , f = 1.0 MHz		-	84	-	
Effective Output Capacitance	C <sub>oss</sub> eff.	$V_{GS} = 0 V$		-	159	-	
Effective Output Capacitance (Energy Related)	C <sub>oss</sub> eff. (ER)		$V_{DS} = 0 V \text{ to } 400 V$	-	120	-	
Internal Gate Resistance	R <sub>g</sub>	f = 1 MHz, open drain		-	1.4	=.	Ω
Total Gate Charge	Qg	10.4.77 400.77		-	-	130	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 16 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 7 and 15 <sup>b</sup>		-	33	nC
Gate-Drain Charge	$Q_{gd}$		see lig. I and 15	-	-	59	
Turn-On Delay Time	t <sub>d(on)</sub>	.,,	050 // 1 40 4	-	21	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 250 \text{ V}, I_{D} = 16 \text{ A}$ $R_{G} = 7.5 \Omega, V_{GS} = 10 \text{ V}$		-	51	-	no
Turn-Off Delay Time	t <sub>d(off)</sub>	$H_G = 7.5 \Omega$ , $V_{GS} = 10 V$ see fig. 14a and 14b <sup>b</sup>		-	50	-	ns
Fall Time	t <sub>f</sub>			-	28	-	
<b>Drain-Source Body Diode Characteristic</b>	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	16	_
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	64	A
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 16  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C		-	170	250	no
		T <sub>J</sub> = 125 °C	I <sub>F</sub> = 16 A,	-	220	330	ns
Dady Diada Dayres Dayres Observed	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C	$dI/dt = 100 A/\mu s^b$	-	470	710	μC
Body Diode Reverse Recovery Charge		T <sub>J</sub> = 125 °C		-	810	1210	μΟ
Reverse Recovery Current	I <sub>RRM</sub>	T <sub>J</sub> = 25 °C		-	7.3	11	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn-	on is dor	ninated b	v L c and	T 2)

<sup>a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. C<sub>OSS</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>OSS</sub> while V<sub>DS</sub> is rising fom 0 % to 80 % V<sub>DS</sub>. C<sub>OSS</sub> eff. (ER) is a fixed capacitance that stores the same energy as C<sub>OSS</sub> while V<sub>DS</sub> is rising fom 0 % to 80 % V<sub>DS</sub>.</sup> 

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

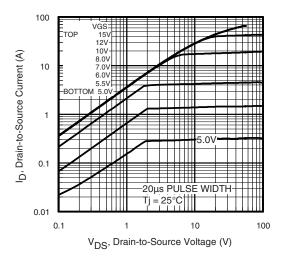


Fig. 1 - Typical Output Characteristics

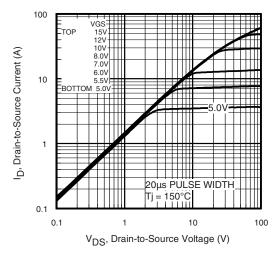


Fig. 2 - Typical Output Characteristics

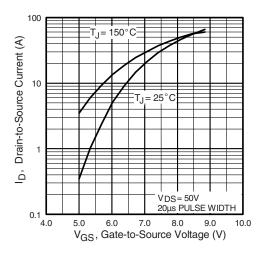


Fig. 3 - Typical Transfer Characteristics

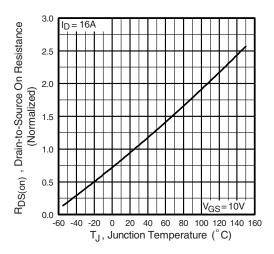


Fig. 4 - Normalized On-Resistance vs. Temperature



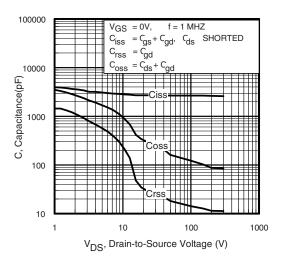


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

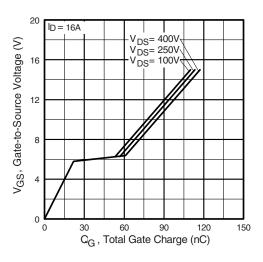


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

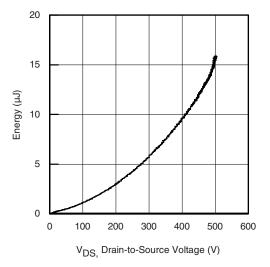


Fig. 6 - Typ. Output Capacitance Stored Energy vs. V<sub>DS</sub>

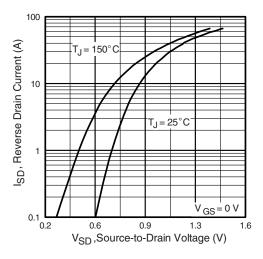


Fig. 8 - Typical Source-Drain Diode Forward Voltage



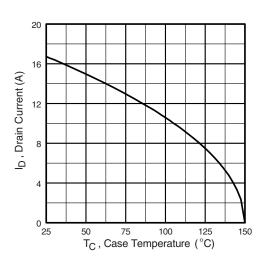


Fig. 9 - Maximum Drain Current vs. Case Temperature

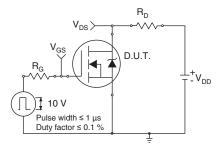


Fig. 10a - Switching Time Test Circuit

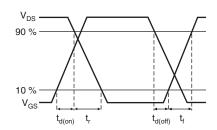


Fig. 10b - Switching Time Waveforms

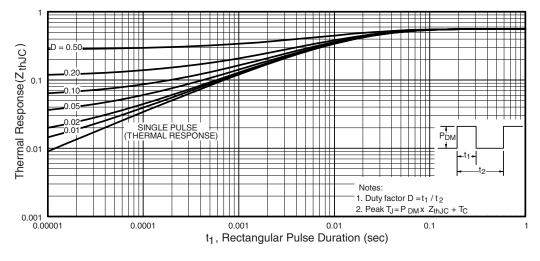


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



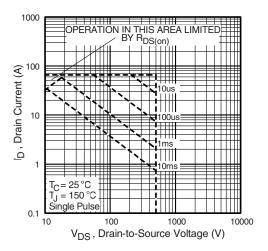


Fig. 12 - Maximum Safe Operating Area

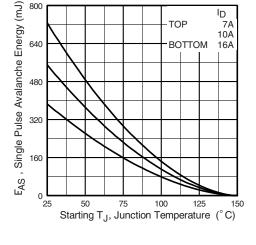


Fig. 13 - Maximum Avalanche Energy vs. Drain Current

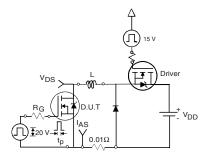


Fig. 14a - Unclamped Inductive Test Circuit

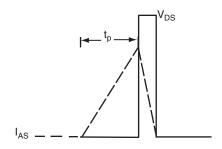


Fig. 14b - Unclamped Inductive Waveforms

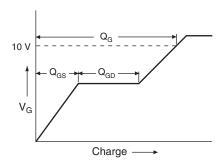


Fig. 15a - Basic Gate Charge Waveform

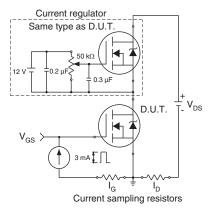
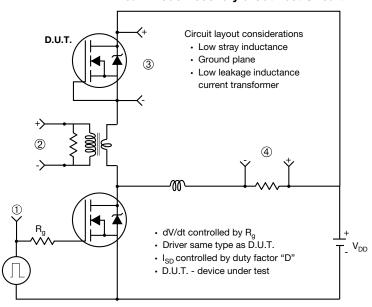


Fig. 15b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



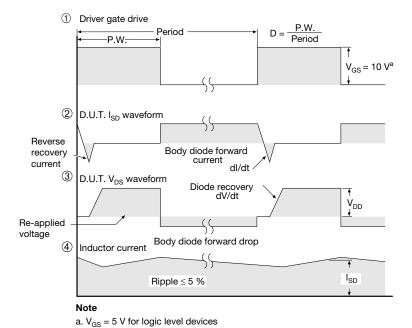


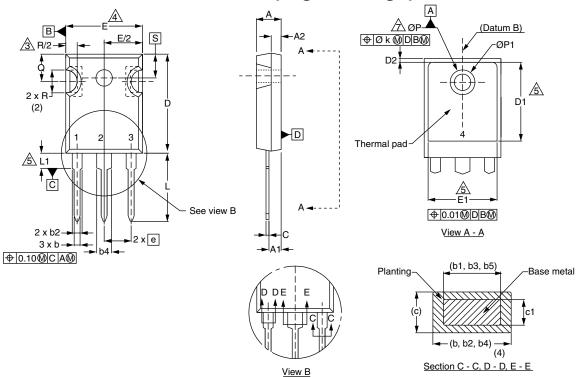
Fig. 16. For N-Channel

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www.vishay.com

Vishay Siliconix

# **TO-247AC (High Voltage)**



	MILLIM	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.58	5.31	0.180	0.209	
A1	2.21	2.59	0.087	0.102	
A2	1.17	2.49	0.046	0.098	
b	0.99	1.40	0.039	0.055	
b1	0.99	1.35	0.039	0.053	
b2	1.53	2.39	0.060	0.094	
b3	1.65	2.37	0.065	0.093	
b4	2.42	3.43	0.095	0.135	
b5	2.59	3.38	0.102	0.133	
С	0.38	0.86	0.015	0.034	
c1	0.38	0.76	0.015	0.030	
D	19.71	20.82	0.776	0.820	
D1	13.08	-	0.515	-	
FON V40 0407 Pr. P. 04 0 40					

	MILLIM	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D2	0.51	1.30	0.020	0.051
Е	15.29	15.87	0.602	0.625
E1	13.72	-	0.540	-
е	5.46	BSC	0.215 BSC	
Øk	0.254		0.010	
L	14.20	16.25	0.559	0.640
L1	3.71	4.29	0.146	0.169
N	7.62 BSC		0.300 BSC	
ØΡ	3.51	3.66	0.138	0.144
Ø P1	-	7.39	-	0.291
Q	5.31	5.69	0.209	0.224
R	4.52	5.49	0.178	0.216
S	5.51 BSC		0.217	BSC

ECN: X12-0167-Rev. B, 24-Sep-12

DWG: 5971

#### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
- 5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



Revision: 24-Sep-12 Document Number: 91360



## **Legal Disclaimer Notice**

Vishay

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